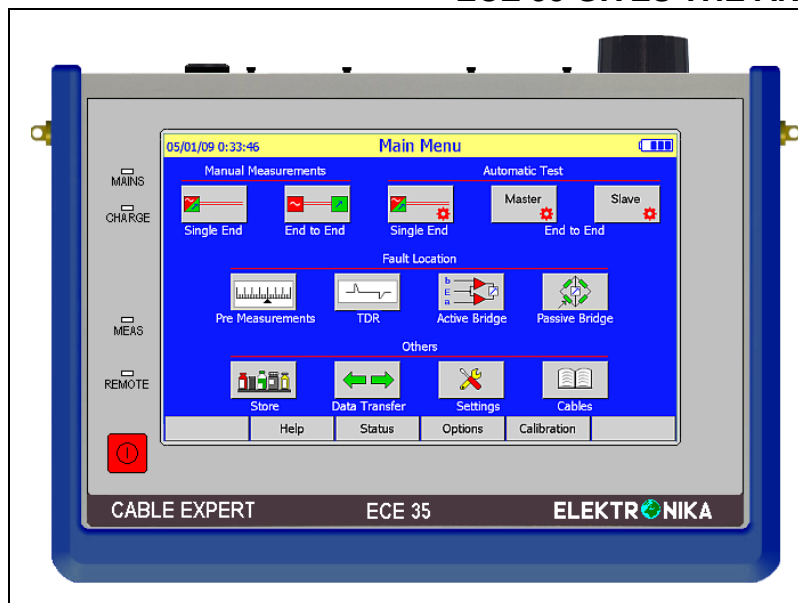


IS THIS PAIR SUITABLE FOR YOUR SYSTEM? IF NOT WHERE IS THE FAULT?



ECE 35 GIVES THE ANSWER!



ECE 35 is an advanced hand-held instrument providing powerful tools for qualification and fault location of copper pairs used for various xDSL and voice frequency telecommunication services.

TWO INSTRUMENTS IN ONE

- Sophisticated Line Qualifier
- Precision Cable Fault Locator

TOOLS for LINE QUALIFICATION

- 35 MHz Transmitter
- 35 MHz Receiver
- Spectrum Analyzer
- Z, Return Loss, LCL measurements
- Phone Simulator

TOOLS for CABLE FAULT LOCATION

- Active Bridge & DMM
- Passive Wheatstone Bridge
- Graaf Fault Locator
- TDR

LINE QUALIFICATION

MANUAL MEASUREMENTS

For the test of principal characteristics on xDSL and voice frequency lines

Single Sided Measurements

Impedance, Return Loss, LCL, NEXT, WB Noise, Impulse Noise, Spectrum Analyzer, Loss estimation for xDSL lines and Echo for VF lines

End to End Measurements

Loss, Interruption, Group Delay, Noise with Tone, Jitter and Frequ.-error, Simultaneous Event Counter

AUTOMATIC MASTER SLAVE TEST

Tolerance masks of cable parameters as Loss, LCL, Return Loss, Impedance, and the principal system parameters are pre-programmed for VDSL, ADSL, SHDSL, HDSL, ISDN, VF systems. In that mode ECE 35 provides:

Automatic Data Rate Calculation
Immediate PASS/FAIL indication

SPECIAL ADVANCED SW OPTIONS

Spectrogram

In that mode ECE 35 performs repeated spectrum measurements in every second and the obtained results are displayed up to 72 hours in the form of "water-fall" diagram. That method is an excellent tool to discover disturbers appearing in unpredictable times and frequency ranges.

Non disturbing test beside vectored groups

The operation of vectored group can be interrupted if the alien noise exceeds a certain limit therefore the traditional test methods are not applicable. ECE 35 provides non disturbing special test methods for the measurement beside vectored lines

CABLE FAULT LOCATION

ACTIVE BRIDGE MEASUREMENTS

For accurate location of faults where the level of disturbing voltages are low.

DC Fault Location Methods

Murray, 3 Point, K upfm uller, Repeated K upfm uller and Resistance Difference

AC Fault Location Methods

Interruption, Repeated K upfm uller, C Balance

PASSIVE BRIDGE MEASUREMENTS

For accurate location of faults where the level of disturbing voltages are high.

DC Fault Location Methods

Murray, 3 Point, K upfm uller, R Difference

AC Fault Location Methods

K upfm uller, C Balance

GRAAF FAULT LOCATION

For fault location on totally water-soaked cable if the disturbing voltages are high and intermittent.

TDR MEASUREMENTS

To find low impedance faults and splits causing cross talk between the pairs.

Single Pair Modes

Short Time L1 or L2, Long Time L1 or L2

Double Pair Modes

XTALK, L1 & L2 or L1-L2

Memory Modes

Memory & L1 or Memory - L1

Automatic Configuration

For L1 and XTALK measurements

DMM MEASUREMENTS

Loop and Insulation resistance, Capacitance, AC/DC Voltage, DC Current
Automatic Cable State Survey

BASIC MEASURING MODES FOR LINE QUALIFICATION

<p>Manual Measuring Modes</p> <ul style="list-style-type: none"> • Transmitting • Selective Receiver • Wideband Receiver • NEXT • LCL Balance • Impedance • Return loss • Wideband Noise • Impulse Noise • Spectrum Analyzer 	<p>Automatic Master/Slave xDSL Line Test (DELT)</p> <ul style="list-style-type: none"> • Templates for SVDSL, VDSL2, ADSL2+, ADSL2, ADSL, READSL, SHDSL HDSL and ISDN systems • Loss, Noise, Impedance, Return Loss, Balance, NEXT and FEXT measurements • Bit load & Achievable bit rate calculation <p>Automatic Master/Slave VF Line Test (DELT)</p> <ul style="list-style-type: none"> • Templates for Active, Passive and Switched voice frequency lines • Loss, Noise, Total Distortion, Impedance, Return Loss, Balance, NEXT and FEXT measurements
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SW OPTIONS FOR LINE QUALIFICATION

<p>Spectral Trace as Reference</p> <ul style="list-style-type: none"> • Stored spectrum as reference and • System dependent PSD as reference <p>Spectrogram</p> <ul style="list-style-type: none"> • Repeated spectrum measurements in every second up to 72 hours <p>Test Beside Vectored Groups</p> <ul style="list-style-type: none"> • Non-disturbing test beside VDSL2 groups. • Non-disturbing test beside SVDSL groups <p>Interruption Analysis</p>	<p>Automatic Single Ended xDSL Line Test (SELT)</p> <ul style="list-style-type: none"> • Single End Loss, Noise estimation, • Bit load & Achievable bit rate estimation • Impedance, Return Loss, Balance, NEXT <p>Voice frequency SW package</p> <ul style="list-style-type: none"> • Noise with tone measurement • Group delay distortion measurement • Phase jitter and Frequ. error measurement • Simultaneous Event counters • Echo test
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ACTIVE BRIDGE FOR CABLE FAULT LOCATION (HW Option)

<p>DC Fault Location</p> <ul style="list-style-type: none"> • Loop Resistance • Resistance Difference • Insulation Resistance • Murray, • 3 Point, • Küpfmüller • Repeated Küpfmüller <p>AC Fault Location</p> <ul style="list-style-type: none"> • Capacitance • Capacitive Balance • Interruption • Repeated Küpfmüller <p>Telephone Simulator</p>	<p>TDR</p> <ul style="list-style-type: none"> • Single Pair • Double Pair • Comparison to Memory <p>DMM</p> <ul style="list-style-type: none"> • AC DC Voltage • DC Current • Resistance • Insulation Resistance • Capacitance <p>Automatic Test Sequences</p> <ul style="list-style-type: none"> • Quick Test • Quality Test • Pair Condition Survey
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EXTENSIONS FOR ACTIVE BRIDGE

<p>PASSIVE BRIDGE (HW Option)</p> <p>DC Fault Location</p> <ul style="list-style-type: none"> • Loop Resistance • Resistance Difference • Insulation Resistance • Murray, 3 Point, Küpfmüller, Synchronous Graaf Method <p>AC Fault Location</p> <ul style="list-style-type: none"> • Capacitive Balance, Küpfmüller <p>TEST OF LOADED CABLES (SW Option)</p> <p>TEST OF MULTI SECTION CABLES (SW Option)</p>
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SPECIFICATIONS OF LINE QUALIFIER FUNCTIONS

Transmitter

Outputs (Balanced)
 10 kHz to 35 MHz 100, 135, 150 Ω
 200 Hz to 10 kHz 600 Ω

Frequency
 Frequency Range 200 Hz to 35 MHz
 Frequency resolution 1 Hz
 Frequency accuracy $2 \times 10^{-6} \pm 1$ Hz

Transmitting modes One frequency/MTTS/Sweep

Output level
 10 kHz to 35 MHz +10 to -40 dBm
 200 Hz to 10 kHz +4 to -45 dBm
 Level Resolution 0.1 dB

Accuracy at 0 dBm
 200 Hz to 10 kHz $\pm 0,5$ dB
 10 kHz to 6 MHz $\pm 0,3$ dB
 6 MHz to 35 MHz ± 1 dB

Receiver

Inputs (Balanced)
 10 kHz to 35 MHz 100, 135, 150 Ω or High
 200 Hz to 10 kHz 600 Ω or High

Selective Level Measurement

Frequency
 Frequency Range 200 Hz to 35 MHz
 Frequency resolution 1 Hz
 Frequency accuracy $2 \times 10^{-6} \pm 1$ Hz

Receiving modes One frequency/MTTS/Sweep

Band width
 200 Hz to 10 kHz 20 Hz
 10 kHz to 6 MHz 20, 200 Hz, 1.74, 1.95, 3.1 kHz
 6 MHz to 18 MHz 200 Hz, 1.74, 1.95, 3.1 kHz
 18 MHz to 35 MHz 1.74, 1.95, 3.1 kHz

Measuring Range
 10 kHz to 35 MHz -120 to +10 dBm
 200 Hz to 10 kHz -120 to +4 dBm
 Level Resolution 0.1 dB

Accuracy at 0 dBm
 200 Hz to 10 kHz $\pm 0,5$ dB
 10 kHz to 6 MHz $\pm 0,3$ dB
 6 MHz to 30 MHz $\pm 1,5$ dB

Wideband Level Measurement

Frequency Range 200 Hz to 35 MHz

Measuring Range
 10 kHz to 35 MHz -50 to +10 dBm
 200 Hz to 10 kHz -50 to +4 dBm
 Level Resolution 0.1 dB

Accuracy at 0 dBm
 200 Hz to 10 kHz $\pm 0,5$ dB
 10 kHz to 6 MHz $\pm 0,3$ dB
 6 MHz to 35 MHz $\pm 1,5$ dB

Spectrum Analyzer

Frequency range 200 Hz to 35 MHz

Line impedances
 10 kHz to 30 MHz 100, 135, 150 Ω or High
 200 Hz to 10 kHz 600 Ω or High

Display range down to -140 dBm/Hz

Maximum input level
 200 Hz to 10 kHz +4 dBm
 10 kHz to 35 MHz +10 dBm
 With high impedance active probe +20 dBm

Bandwidth and frequency step

Frequency Range	Bandwidth & Freq. Step
35 MHz	500 Hz to 120 kHz
18 MHz	500 Hz to 60 kHz
12 MHz	500 Hz to 40 kHz
9 MHz	500 Hz to 30 kHz
3 MHz	500 Hz to 10 kHz
1.5 MHz	500 Hz to 5 kHz
600 kHz	500 Hz to 2 kHz
300 kHz	500 Hz to 1 kHz
20 kHz	50 Hz to 100 Hz
4 kHz	10 Hz to 20 Hz
0.3 kHz	1 Hz

Number of displayed frequencies 300
 Saving of result the actual content of display
 Evaluation NORM, PEAK, AVG, SAVG
 Units dBm, dBm/Hz

LCL Measurement

Frequency Range 200 Hz to 35 MHz

Display range 0 to 70 dB

Accuracy for all impedances at 35 dB
 200 Hz to 100 kHz ± 2 dB
 100 kHz to 5 MHz ± 1 dB

Accuracy for 100 Ohm at 35 dB
 5 MHz to 30 MHz $\pm 2,5$ dB

Impedance Measurement

Measuring range
 10 kHz to 35 MHz 50 to 400 Ohm
 200 Hz to 10 kHz 300 to 1600 Ohm

Accuracy
 200 Hz to 10 kHz $\pm 10\% \pm 5$ Ohm
 10 kHz to 18 MHz $\pm 5\% \pm 5$ Ohm
 18 MHz to 30 MHz $\pm 10\% \pm 5$ Ohm

Return Loss Measurement

Impedance
 10 kHz to 35 MHz 100, 135, 150 Ω
 200 Hz to 10 kHz 600 Ω

Display range 0 to 40 dB

Accuracy at 20 dB
 200 Hz to 18 MHz ± 2 dB

Next Measurement

Frequency range 200 Hz to 35 MHz
 Impedances
 10 kHz to 35 MHz 100, 135, 150 Ω Balanced
 200 Hz to 10 kHz 600 Ω Balanced
 Measuring modes One frequency, Sweep
 Measuring range up to 80 dB

Wideband Noise Measurement

Frequency range 200 Hz to 35 MHz
 Filters None, Psophometric, 3,1 kHz Flat,
 ADSL, ADSL 2+, VDSL 1, VDSL 2-8,
 VDSL 2-12, VDSL 2-17, SVDSL-35
 Measuring time selectable 1sec to 72 hours
 Evaluation
 For 1 sec to 1 min Quasi analogue
 Over 1 min Histogram with 60 time slots

Impulse Noise Measurement

Pulse width >500 ns
 Interval size >10 ms
 Threshold range 1 to 500 mV
 Maximum count 65000
 Measuring time selectable 1sec to 72 hours
 Evaluation
 For 1 sec to 30 s Quasi analogue
 Over 30 s Histogram with 60 time slots

Interruption Analysis

Test signal 1020 Hz, 0 to -30 dBm
 Impedance 600 Ω
 Threshold below the normal level 3, 6, 10, 20 dB
 Accuracy of Threshold
 For 3, 6, 10 dB ± 1 dB
 For 20 dB ± 2 dB
 Measuring time selectable 4min to 72 hours
 Interruption Categories 0.6 ms to >1 min
 Evaluation Relative duration, Errored sec
 Count & time distribution / category

Single-End Insertion Loss Measurement

Frequency ranges 1.5, 3, 9, 12, 18, 35 MHz
 Line length range 100 m to 6 km
 Direct measurement 100 kHz to 6 MHz or
 up to 45 dB cable loss
 Extrapolation Over 6 MHz or
 Over 45 dB cable loss
 Vertical scale 0 to 80 dB
 Accuracy 2 to 4 dB
 (The accuracy and the maximum length depends
 on the cable conditions)

Echo Test

Measuring range up to 2500 ms
 Resolution 5 ms
 Display range 0 to -90 dB

Telephone Simulator

Dialing Pulse & Tone
 Storage of phone numbers Provided
Indications
 Line voltage up to 100V
 Line current up to 100 mA
 Ringing voltage up to 100V p-p

Simultaneous Event Counting

Transmitter
 Test signal 1020 Hz
 Test signal level 0 dBm
 Receiver
 Level range 0 to -30 dBm
 Measurement times 5, 15, 30, 60 min
 Maximum counts for each counter 65000
Amplitude Hit Counter (O.95)
 Threshold range 2 to 9 dB
 Guard interval 4 ms
 Dead time 125 ± 25 ms
 Dead time after interruption (>10 dB drop) 1 s
Phase Hit Counter (O.95)
 Threshold range 5 to 45 °
 Guard interval 4 ms
 Dead time 125 ± 25 ms
Interruption Counter (O.61)
 Threshold 6, 10 dB
 Guard interval 2 ms
 Dead time 3 ± 1 ms
Impulsive Noise Counter (O.71)
 Filter 1020 Hz Notch
 Guard interval 20 μ s
 Dead time 125 ± 25 ms
 Threshold range 0 to -50 dBm

Group Delay Distortion (O.81 app. I)

Transmitter
 Test signal 36MTT, 200 to 3700 Hz
 Resolution 100 Hz
 Output level -20 dBm/tone (3dBm peak)
 Receiver
 Input level range -50 to -10 dB/tone
 Group delay distortion range 0 to 5 ms
 Resolution 1 μ s
 Reference smallest, 800 Hz, 1000 Hz, 1800 Hz

Phase Jitter & Frequ. Error Measurement

Transmitter
 Test signal 1020 Hz
 Test signal level 0 dBm
 Receiver
 Test signal level 0 to -30 dBm
Phase Jitter measurement (O.91)
 Measuring Range 0.2 to 30.0 degrees p-p
 Filter 4 to 300 Hz
Frequ. Error Measurement (O.91)
 Measuring Range ± 30 Hz
 Resolution 0.1 Hz

Noise with Tone Measurement

Transmitter
 Test signal 1020 Hz
 Test signal level 0 dBm
 Receiver
 Measuring range 0 to -80 dBm
 Filters Psophometric (O.41)
 1020 Hz Notch (O.132)

PASSIVE BRIDGE

PRE MEASUREMENTS

Loop Resistance	
Measuring range	1 Ω to 10 kΩ
Accuracy	±0.3% ±0.3 Ω
Insulation Resistance	
Measuring ranges	
Measuring ranges.....	10 kΩ to 300 MΩ 10 kΩ to 10 GΩ
Measuring voltage..... 100 V	
Accuracy	
100 kΩ to 50 MΩ	5 %
50 MΩ to 100 MΩ	10 %
100 MΩ to 5 000 MΩ	20 %
5 000 MΩ to 10 000 MΩ	30 %
Resistance Difference	
Loop resistance range	1 Ω to 5000 Ω
Accuracy	±0.2% of RI ±0.2 Ω
Resolution of Lx/L (Mk)-value	
In range ΔR <10%	1/10000
In range ΔR >10%	1/1000
DC Fault Location	
Test methods Murray, Küpfmüller, 3 Point	
Loop resistance range	1 Ω to 10 kΩ
Fault resistance range	up to 100 MΩ
Measuring voltage.....	100 V
Accuracy (RI=2 kΩ, Lx/L=0,1 to 1)	
Fault resistance < 1 MΩ.....	0.2 %
Fault resistance 1 MΩ to 5 MΩ	0.3 %
Fault resistance 5 MΩ to 25 MΩ.....	0.5 %
Fault resistance 25 MΩ to 100 MΩ.....	2 %
Resolution of Lx/L (Mk) value	1/1000
AC Fault Location Küpfmüller Method	
Loop resistance range	1 Ω to 10 kΩ
Fault resistance range.	up to 25 MΩ
Measuring voltage.....	11 Hz, 100 Vp
Accuracy (RI=2 kΩ, Lx/L=0,1 to 1)	
Fault resistance < 1 MΩ.....	±0.3%
Fault resistance 1 MΩ to 5 MΩ	±0.5%
Fault resistance 5 MΩ to 25 MΩ.....	±1.0%
Resolution of M value	1/1000
AC Capacitive Balance	
Measuring range.	10 nF to 2 μF
Accuracy of Lx/L value	±0.2%
Measuring voltage.....	11 Hz, 100 Vp
Resolution of Lx/L value	
In range Lx/L=0.9 to 1.1.....	1/10000
In range Lx/L<0.9 or Lx/L>1.1	1/1000
Fault Location Graaf Method	
Loop resistance range	10 Ω to 10 kΩ
DC current range.	10 μA to 0.1A
Accuracy of current measurement.....	±0.3% ±2μA
Accuracy of Lx/L value (current >0.1mA)	±3%
Accuracy of Lx/L value (current >1mA)	±0.3%

Disturbing Voltage	
DC voltage.	up to 400 V
AC voltage.....	up to 250 V eff
Accuracy	±3 % ±.1 V
Frequency range	15 to 300 Hz
Input resistance	2 MΩ
Loop Resistance	
Measuring range	1 Ω to 10 kΩ
Accuracy	±0.5 % ±0.2 Ω
Insulation Resistance	
Measuring range.....	10 kΩ to 1 GΩ
Measuring voltage	100 V
Accuracy (without disturbing DC voltage)	
Up to 300 MΩ	20 %
DC Current	
Measuring range.....	10μA to 0.1A
Accuracy	±0.3 % 2 μA
Capacitance	
Measuring range	10 nF to 2 μF
Measuring voltage	11 Hz, 100 Vp
Accuracy	±3% ±0.3 nF

AUTOMATIC QUICK TEST

Disturbing Voltage	
Measuring range.	up to 400 V DC, 250 V AC
Test results	Vab, VaE and VbE
Insulation	
Measuring range	10 kΩ to 300 MΩ
Measuring voltage.....	100 V
Capacitance	
Measuring range	10 nF to 2 μF
Capacitive Balance	
Test result	Unbalance %
Measuring voltage	11 Hz, 100 Vp

AUTOMATIC QUALITY TEST

Insulation	
Measuring range	10 kΩ to 10 GΩ
Capacitance	
Measuring range	10 nF to 2 μF
Capacitive Balance	
Test result	Unbalance %
Resolution	1/1000
Loop Resistance	
Measuring range	1 Ω to 10kΩ
Accuracy	±0.3% ±0.1 Ω
Resistance Difference	
Loop resistance range	1 Ω to 5 kΩ
Resolution	1/1000

PAIR CONDITION SURVEY

The Survey of Pair Condition is extremely useful test sequence to find the best fault location method.
 The consists of the following measurements:

- **Disturbing voltage**
- **Capacitance**
- **Loop and wire resistances**
- **Insulation resistances**



DATA TRANSFER

Data transfer via USB port

The USB port provides:

- bidirectional transfer of test results
- bidirectional transfer of test setups
- transfer of print screen images to USB stick
- transfer of upgrade files to ECE 35

Data transfer via WiFi

The WiFi connection provides two ways of transferring test results, test setups and images to LAN network:

- ECE 35 initiates a connection to a FTP server
- ECE 35 acts as a HTTP server

LOOP CLOSING DEVICE ELC 30 (Accessory)

Functions

Opening or closing the far end of tested pair when just one person wants to perform a measurement during which the far endings should be opened or closed (e.g. K pfm ller method).

The device is remote controlled over the tested pair by ECE 35



Specifications

Power supply

AA size alkaline battery cells 3 pieces
 Operation time ca. 1000 hours
 Auto power off 4 hours

Connectors 4 mm banana plugs

Mechanical Data

Dimensions 110 x 60 x 25 mm
 Weight (Including battery pack) ca. 0,2 kg

INTELLIGENT SLAVE ECFL 30S (Accessory)

Functions

Opening or closing the far end of tested pair when just one person wants to perform a measurement during which the far endings should be opened or closed (e.g. K pfm ller method).

Current measurement at the far end of the tested pair when Graaf method is applied. In case of Graaf method the master ECE 35 and the remote controllable intelligent slave ECFL 30S measure the current at the two cable ends at the same time and communicate over the tested pair. The Master calculates the location of fault out of the rate of currents



Specifications

Power Supply

AA size alkaline battery cells4 pieces
 Operation time ca. 500 hours
 Auto power off 4 hours

Connectors

A, B, C line connectors ..4 mm banana sockets
 Ground connector 4 mm banana socket

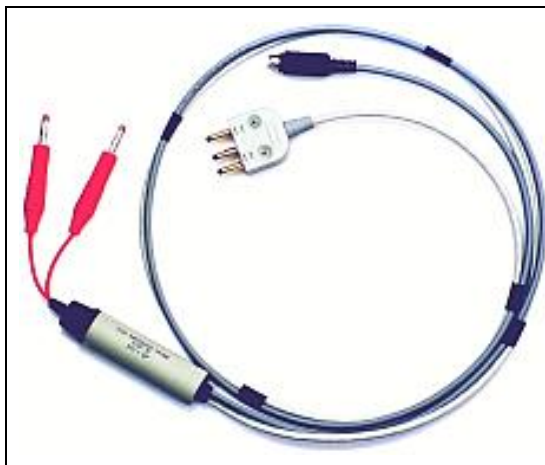
Mechanical Data

Dimensions 210 x 100 x 40 mm
 Weight (Including battery pack) ca. 0,4 kg

Control

The device is remote controlled over the test-pair by ECE 35

HIGH IMPEDANCE PROBE ELQP 30 (Accessory)



Purpose

The ELQP 30 active probe is intended for PSD spectrum measurement on working lines when test instrument should be connected parallel with the operating modems and the regular measuring cables can not be used because the digital systems are extremely sensitive for the capacitive load

Specifications

Frequency range5 kHz to 30 MHz
 Attenuation 15 dB
 Input Impedance 5 kOhm || 5pF
 Accuracy
 5 kHz to 25 kHz ±1dB
 25 kHz to 5 MHz ±0.3 dB
 5 MHz to 30 MHz ±1dB
 Powered from ECE 35

